

Data Sheet

January 3, 2006

80V, 1.25A Peak Current H-Bridge FET Driver

intercil

The HIP4082 is a medium frequency, medium voltage H-Bridge N-Channel MOSFET driver IC, available in 16 lead plastic SOIC (N) and DIP packages.

Specifically targeted for PWM motor control and UPS applications, bridge based designs are made simple and flexible with the HIP4082 H-bridge driver. With operation up to 80V, the device is best suited to applications of moderate power levels.

Similar to the HIP4081, it has a flexible input protocol for driving every possible switch combination except those which would cause a shoot-through condition. The HIP4082's reduced drive current allows smaller packaging and it has a much wider range of programmable dead times (0.1 to 4.5µs) making it ideal for switching frequencies up to 200kHz. The HIP4082 does not contain an internal charge pump, but does incorporate non-latching level-shift translation control of the upper drive circuits.

Features

- Independently Drives 4 N-Channel FET in Half Bridge or Full Bridge Configurations
- Bootstrap Supply Max Voltage to 95VDC
- Drives 1000pF Load in Free Air at 50°C with Rise and Fall Times of Typically 15ns
- User-Programmable Dead Time (0.1 to 4.5μs)
- DIS (Disable) Overrides Input Control and Refreshes Bootstrap Capacitor when Pulled Low
- Input Logic Thresholds Compatible with 5V to 15V Logic Levels
- Shoot-Through Protection
- Undervoltage Protection
- Pb-Free Plus Anneal Available (RoHS Compliant)

Applications

- UPS Systems
- · DC Motor Controls

This set of features and specifications is optimized for applications where size and cost are important. For Full Bridge Pewer-Supplies S Switching Fower Amplifiers applications needing higher drive capability the H and HIP4081A are vecommended. P4080A

Ordering Information

PART NUMBER	PART MARKING	TEMP. RANGE (°C)	PACKAGE	PKG. DWG. #
HIP4082IB*	HIP4082IB	-55 to +125	16 Ld SOIC (N)	M16.15
HIP4082IBZ* (Note)	4082IBZ	-55 to +125	16 Ld SOIC (N) (Pb-free)	M16.15
HIP4082IP	HIP4082IP	-55 to +125	16 Ld PDIP	E16.3
HIP4082IPZ (Note)	HIP4082IPZ	-55 to +125	16 Ld PDIP** (Pb-free)	E16.3

*Add "-T" suffix for tape and reel.

NOTE: Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/ JEDEC J STD-020.

**Pb-free PDIPs can be used for through hole wave solder processing only. They are not intended for use in Reflow solder processing applications.

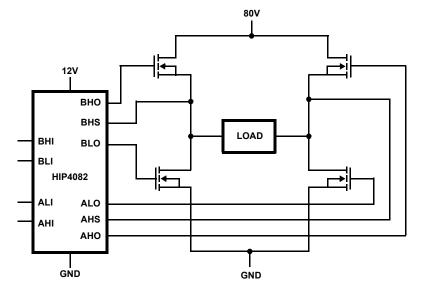
- Noise Cancellation Systems
- · Battery Powered Vehicles
- · Peripherals
- Medium/Large Voice Coil Motors
- Related Literature
 - TB363, Guidelines for Handling and Processing Moisture Sensitive Surface Mount Devices (SMDs)

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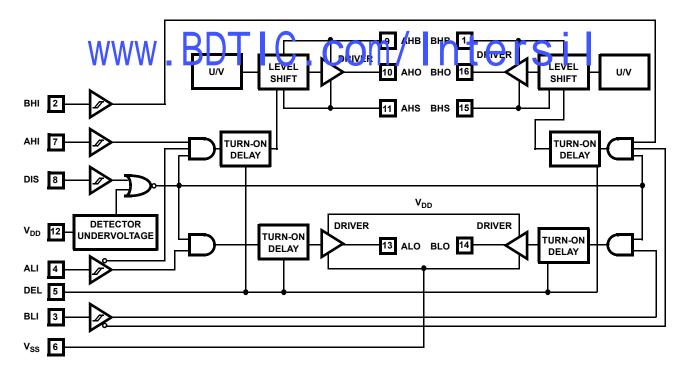
Pinout

	HIP4082 (PDIP, SOIC TOP VIEW)
внв [16 вно
BHI	2	15 BHS
BLI	3	14 BLO
ALI	4	13 ALO
DEL	5	12 V_{DD}
v _{ss}	6	11 AHS
AHI	7	10 AHO
DIS	8	9 AHB

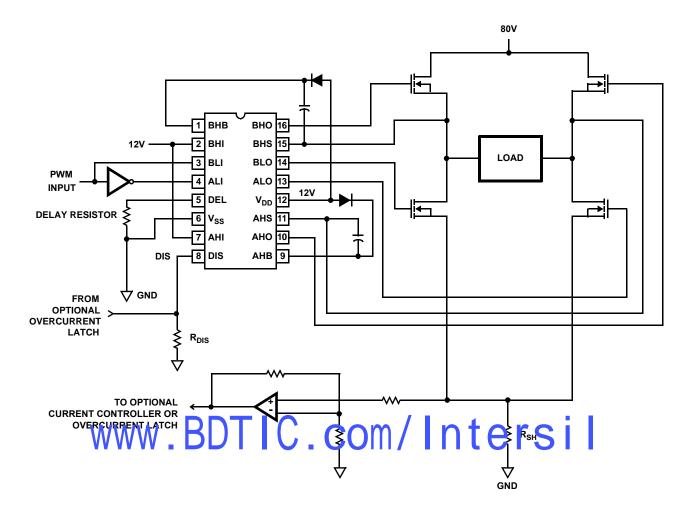
Application Block Diagram



Functional Block Diagram







Absolute Maximum Ratings

Cumply(A(trans)) = Cumply(A(trans))
Supply Voltage, V _{DD} 0.3V to 16V
Logic I/O Voltages
Voltage on AHS, BHS6V (Transient) to 80V (25°C to 150°C)
Voltage on AHS, BHS6V (Transient) to 70V (-55°C to150°C)
Voltage on AHB, BHB V _{AHS, BHS} -0.3V to V _{AHS, BHS} +V _{DD}
Voltage on ALO, BLO V _{SS} -0.3V to V _{DD} +0.3V
Voltage on AHO, BHO V _{AHS, BHS} -0.3V to V _{AHB, BHB} +0.3V Input
Current, DEL
Phase Slew Rate
NOTE: All voltages are relative V _{SS} unless otherwise specified.

Operating Conditions

Supply Voltage, V _{DD} +8.5V to +15V	
Voltage on $V_{SS},\ldots\ldots$ -1.0V to +1.0V	
Voltage on AHB, BHBV _{AHS, BHS} +7.5V to V _{AHS, BHS} +V _{DD} Input Current, DEL4mA to -100μA	

Thermal Information

Thermal Resistance	θ _{JA} (°C/W)
SOIC Package	115
DIP Package	90
Maximum Power Dissipation.	
Storage Temperature Range65	°C to +150°C
Operating Max. Junction Temperature	+150°C
Lead Temperature (Soldering 10s)	+300°C
(For SOIC - Lead Tips Only))	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Electrical Specifications $V_{DD} = V_{AHB} = V_{BHB} = 12V$, $V_{SS} = V_{AHS} = V_{BHS} = 0V$, $R_{DEL} = 100K$

			T _J = +25°C			T _J = -55°C TO +150°C		
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	ТҮР	MAX	MIN	MAX	UNITS
SUPPLY CURRENTS & UNDER VOLTAG	E PROTECTION		÷			•		•
V _{DD} Quiescent Current	I _{DD}	All inputs = 0V, R _{DEL} = 100K	1.2	2.3	3.5	0.85	4	mA
		All inputs = 0V, R _{DEL} = 10K	2.2	4.0	5.5	1.9	6.0	mA
V _{DD} Operating Current	I _{DDO}	f = 50kHz, no load	1.5	2.6	4.0	1.1	4.2	mA
	ΠΤΙ(50kHz m load, Ppiil = 10k2	25	1 .0	6.1	2.1	6.6	mA
AHB, BHB Off Quiescent Current 🔹 🏳	I _{AHBL} , I _{BHBL}	AH# = BH# = OV	0.5	1.0	2 1.5	J .4	1.6	mA
AHB, BHB On Quiescent Current	I _{AHBH} , I _{BHBH}	AHI = BHI = V _{DD}	65	145	240	40	250	μA
AHB, BHB Operating Current	I _{AHBO} , I _{BHBO}	f = 50kHz, CL = 1000pF	.65	1.1	1.8	.45	2.0	mA
AHS, BHS Leakage Current	I _{HLK}	$V_{AHS} = V_{BHS} = 80V$ $V_{AHB} = V_{BHB} = 96$ V_{DD} = Not Connected	-	-	1.0	-	-	μA
V _{DD} Rising Undervoltage Threshold	V _{DDUV+}		6.8	7.6	8.25	6.5	8.5	V
V _{DD} Falling Undervoltage Threshold	V _{DDUV-}		6.5	7.1	7.8	6.25	8.1	V
Undervoltage Hysteresis	UVHYS		0.17	0.4	0.75	0.15	0.90	V
AHB, BHB Undervoltage Threshold	VHBUV	Referenced to AHS & BHS	5	6.0	7	4.5	7.5	V
INPUT PINS: ALI, BLI, AHI, BHI, & DIS								
Low Level Input Voltage	V _{IL}	Full Operating Conditions	-	-	1.0	-	0.8	V
High Level Input Voltage	V _{IH}	Full Operating Conditions	2.5	-	-	2.7		V
Input Voltage Hysteresis			-	35	-	-	-	mV
Low Level Input Current	IIL	V _{IN} = 0V, Full Operating Conditions	-145	-100	-60	-150	-50	μA
High Level Input Current	I _{IH}	V _{IN} = 5V, Full Operating Conditions	-1	-	+1	-10	+10	μA
TURN-ON DELAY PIN DEL		·	·	•	•	•	•	
Dead Time	T _{DEAD}	R _{DEL} = 100K	2.5	4.5	8.0	2.0	8.5	μS
		R _{DEL} = 10K	0.27	0.5	0.75	0.2	0.85	μS

Electrical Specifications	$V_{DD} = V_{AHB} = V_{BHB} = 12V$, $V_{SS} = V_{AHS} = V_{BHS} = 0V$, $R_{DEL} = 0V$	= 100K (Continued)
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			T _J = +25°C		°C	T _J = TO +		
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNITS
GATE DRIVER OUTPUT PINS: ALO, BLO,	AHO, & BHO			•				
Low Level Output Voltage	V _{OL}	I _{OUT} = 50mA	0.65		1.1	0.5	1.2	V
High Level Output Voltage	V _{DD} -V _{OH}	I _{OUT} = -50mA	0.7		1.2	0.5	1.3	V
Peak Pullup Current	I _O +	V _{OUT} = 0V	1.1	1.4	2.5	0.85	2.75	А
Peak Pulldown Current	I _O -	V _{OUT} = 12V	1.0	1.3	2.3	0.75	2.5	А

$\label{eq:second} \textbf{Switching Specifications} \quad V_{DD} = V_{AHB} = V_{BHB} = 12 \text{V}, \ V_{SS} = V_{AHS} = V_{BHS} = 0 \text{V}, \ \text{R}_{DEL} = 100 \text{K}, \ \text{C}_{L} = 1000 \text{F}.$

					T _J = +25°C			
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	MIN	MAX	UNITS
Lower Turn-off Propagation Delay (ALI-ALO, BLI-BLO)	T _{LPHL}		-	25	50	-	70	ns
Upper Turn-off Propagation Delay (AHI-AHO, BHI-BHO)	T _{HPHL}		-	55	80	-	100	ns
Lower Turn-on Propagation Delay (ALI-ALO, BLI-BLO)	T _{LPLH}		-	40	85	-	100	ns
Upper Turn-on Propagation Delay (AHI-AHO, BHI-BHO)	T _{HPLH}		-	75	110	-	150	ns
Rise Time	T _R		-	9	20	-	25	ns
Fall Time		oom/L	h f	9	20	-	25	ns
	T-WIN SN/OFF		50		3	50	-	ns
Output Pulse Response to 50 ns Input Pulse	T _{PWOUT}			63			80	ns
Disable Turn-off Propagation Delay (DIS - Lower Outputs)	T _{DISLOW}		-	50	80	-	90	ns
Disable Turn-off Propagation Delay (DIS - Upper Outputs)	T _{DISHIGH}		-	75	100	-	125	ns
Disable Turn-on Propagation Delay (DIS - ALO & BLO)	T _{DLPLH}		-	40	70	-	100	ns
Disable Turn-on Propagation Delay (DIS- AHO & BHO)	T _{DHPLH}	R _{DEL} = 10K	-	1.2	2	-	3	μS
Refresh Pulse Width (ALO & BLO)	T _{REF-PW}		375	580	900	350	950	ns

TRUTH TABLE

		OUT	ГРИТ			
ALI, BLI	AHI, BHI	BHI VDDUV VHBUV DIS			ALO, BLO	AHO, BHO
Х	X	х	х	1	0	0
Х	X	1	х	Х	0	0
0	X	0	1	0	0	0
1	х	0	х	0	1	0
0	1	0	0	0	0	1
0	0	0	0	0	0	0

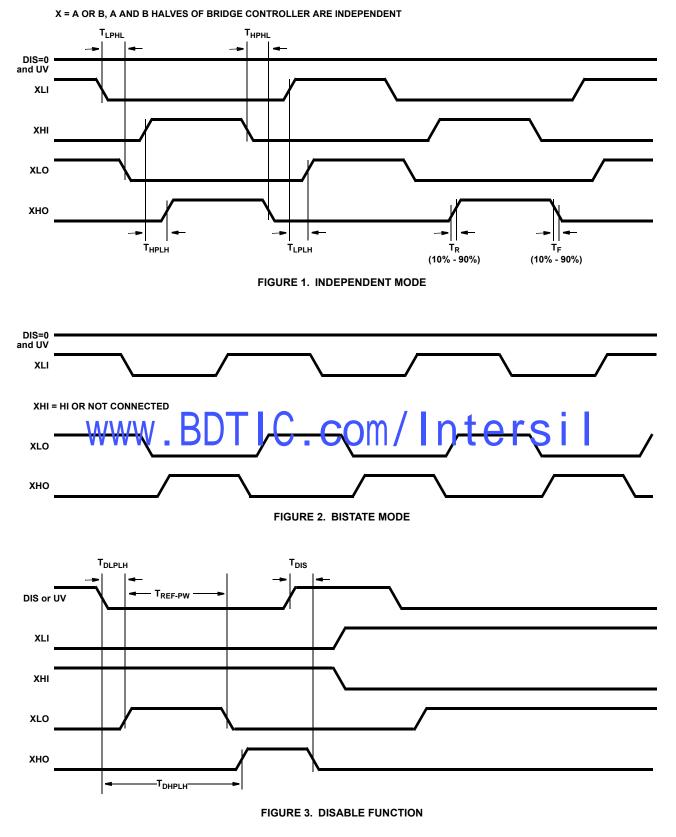
NOTE: X signifies that input can be either a "1" or "0".

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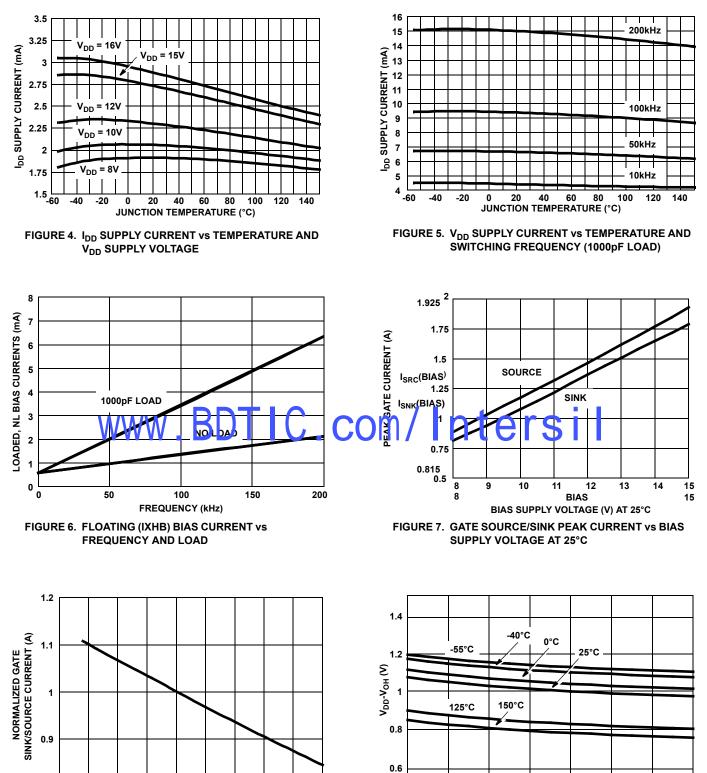
Pin Descriptions

PIN NUMBER	SYMBOL	DESCRIPTION
1	внв	B High-side Bootstrap supply. External bootstrap diode and capacitor are required. Connect cathode of bootstrap diode and positive side of bootstrap capacitor to this pin.
2	BHI	B High-side Input. Logic level input that controls BHO driver (Pin 16). BLI (Pin 3) high level input overrides BHI high level input to prevent half-bridge shoot-through, see Truth Table. DIS (Pin 8) high level input overrides BHI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
3	BLI	B Low-side Input. Logic level input that controls BLO driver (Pin 14). If BHI (Pin 2) is driven high or not connected externally then BLI controls both BLO and BHO drivers, with dead time set by delay currents at DEL (Pin 5). DIS (Pin 8) high level input overrides BLI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
4	ALI	A Low-side Input. Logic level input that controls ALO driver (Pin 13). If AHI (Pin 7) is driven high or not connected externally then ALI controls both ALO and AHO drivers, with dead time set by delay currents at DEL (Pin 5). DIS (Pin 8) high level input overrides ALI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
5	DEL	Turn-on DELay. Connect resistor from this pin to V_{SS} to set timing current that defines the dead time between drivers. All drivers turn-off with no adjustable delay, so the DEL resistor guarantees no shoot-through by delaying the turn-on of all drivers. The voltage across the DEL resistor is approximately Vdd -2V.
6	V _{SS}	Chip negative supply, generally will be ground.
7	AHI	A High-side Input. Logic level input that controls AHO driver (Pin 10). ALI (Pin 4) high level input overrides AHI high level input to prevent half-bridge shoot-through, see Truth Table. DIS (Pin 8) high level input overrides AHI high level input. The pin can be driven by signal levels of 0V to 15V (no greater than V _{DD}).
8	DIS	DISable input. Logic level input that when taken high sets all four outputs low. DIS high overrides all other inputs. When DIS is taken low the outputs are controlled by the other inputs. The pin can be driven by signal levels of 0V to 15V (no greater than V_{DD}).
9	AHB	A High-side Brotytrap sul ply External bootstrap diode and capacitor are required. Connect cathode of bootstrap
10	АНО	A High-side Output. Connect to gate of A High-side power MOSFET.
11	AHS	A High-side Source connection. Connect to source of A High-side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
12	V _{DD}	Positive supply to control logic and lower gate drivers. De-couple this pin to V _{SS} (Pin 6).
13	ALO	A Low-side Output. Connect to gate of A Low-side power MOSFET.
14	BLO	B Low-side Output. Connect to gate of B Low-side power MOSFET.
15	BHS	B High-side Source connection. Connect to source of B High-side power MOSFET. Connect negative side of bootstrap capacitor to this pin.
16	BHO	B High-side Output. Connect to gate of B High-side power MOSFET.





Performance Curves



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0.8 -75 -50 -25 0 25 50 75 100 125 150 JUNCTION TEMPERATURE (°C) FIGURE 8. GATE CURRENT vs TEMPERATURE, NORMALIZED TO 25°C

FIGURE 9. V_{DD}-V_{OH} vs BIAS VOLTAGE TEMPERATURE

V_{DD} SUPPLY VOLTAGE (V)

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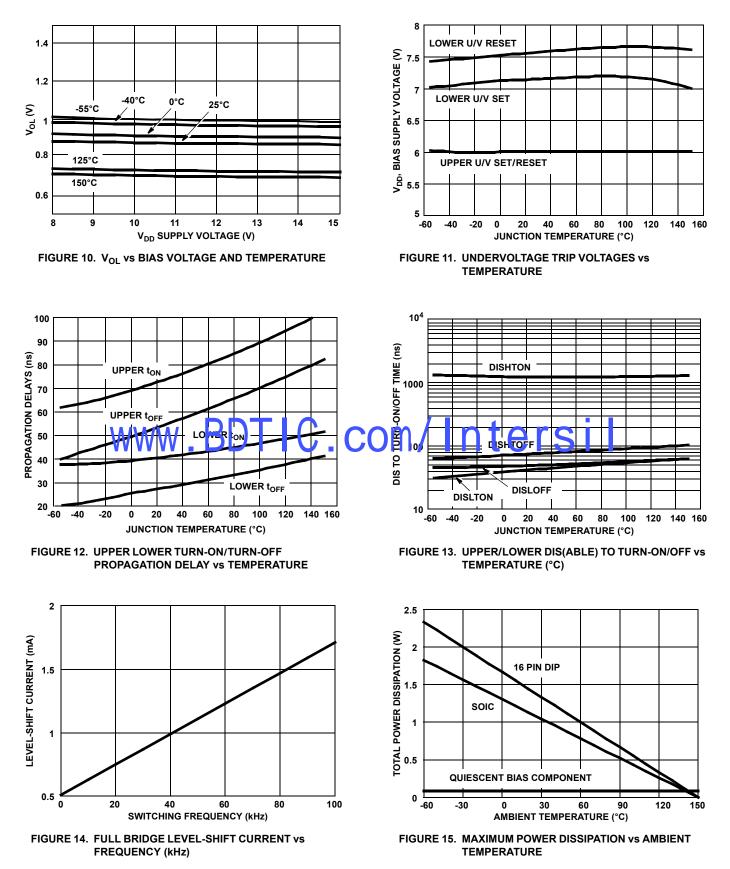
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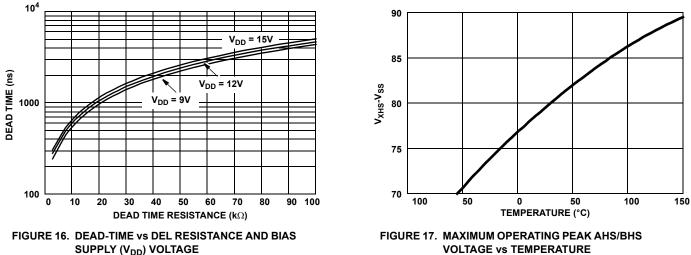
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Performance Curves (Continued)



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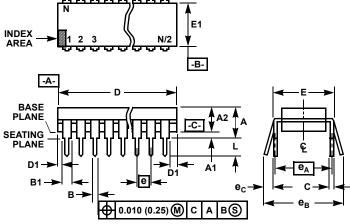
Performance Curves (Continued)



VOLTAGE vs TEMPERATURE

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Dual-In-Line Plastic Packages (PDIP)



NOTES:

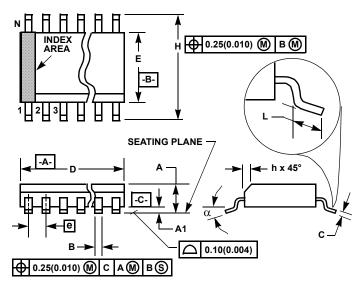
- 1. Controlling Dimensions: INCH. In case of conflict between English and Metric dimensions, the inch dimensions control.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- 3. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication No. 95.
- 4. Dimensions A, A1 and L are measured with the package seated in JE-DEC seating plane gauge GS-3.
- D, D1, and E1 dimensions do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.010 inch (0.25mm).
- 6. E and e_A are measured with the leads constrained to be perpendicular to datum -C-.
- 7. e_B and e_C are in astrel antile lead ins with the lease inconstrained OM / Intersi
- 8. B1 maximum dimensions do not include dambar protrusions. Dambar protrusions shall not exceed 0.010 inch (0.25mm).
- 9. N is the maximum number of terminal positions.
- 10. Corner leads (1, N, N/2 and N/2 + 1) for E8.3, E16.3, E18.3, E28.3, E42.6 will have a B1 dimension of 0.030 0.045 inch (0.76 1.14mm).

E16.3 (JEDEC MS-001-BB ISSUE D) 16 LEAD DUAL-IN-LINE PLASTIC PACKAGE

	INC	HES	MILLIM	IETERS	
SYMBOL	MIN	MAX	MIN	MAX	NOTES
А	-	0.210	-	5.33	4
A1	0.015	-	0.39	-	4
A2	0.115	0.195	2.93	4.95	-
В	0.014	0.022	0.356	0.558	-
B1	0.045	0.070	1.15	1.77	8, 10
С	0.008	0.014	0.204	0.355	-
D	0.735	0.775	18.66	19.68	5
D1	0.005	-	0.13	-	5
E	0.300	0.325	7.62	8.25	6
E1	0.240	0.280	6.10	7.11	5
е	0.100	BSC	2.54	BSC	-
e _A	0.300	BSC	7.62	BSC	6
e _B	-	0.430	-	10.92	7
L	0.115	0.150	2.93	3.81	4
Ν	1	6	1	6	9

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Small Outline Plastic Packages (SOIC)



NOTES:

- 1. Symbols are defined in the "MO Series Symbol List" in Section 2.2 of Publication Number 95.
- 2. Dimensioning and tolerancing per ANSI Y14.5M-1982.
- Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusion and gate burrs shall not exceed 0.15mm (0.006 inch) per side.
- 4. Dimension "E" does not include interlead flash or protrusions. Interlead flash and protrusions shall not excred 0.25mm (0.010 jnch) per side.
- flash and protrusions shall not excred 0.25mm(0.010 inch) per side.
 5. The chamfer on the body is optionar: n if is not present a visual index OM / Intersection of the construction of the
- 6. "L" is the length of terminal for soldering to a substrate.
- 7. "N" is the number of terminal positions.
- 8. Terminal numbers are shown for reference only.
- 9. The lead width "B", as measured 0.36mm (0.014 inch) or greater above the seating plane, shall not exceed a maximum value of 0.61mm (0.024 inch).
- 10. Controlling dimension: MILLIMETER. Converted inch dimensions are not necessarily exact.

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M16.15 (JEDEC MS-012-AC ISSUE C) 16 LEAD NARROW BODY SMALL OUTLINE PLASTIC PACKAGE

	INCHES		MILLIMETERS		
SYMBOL	MIN	MAX	MIN	MAX	NOTES
А	0.0532	0.0688	1.35	1.75	-
A1	0.0040	0.0098	0.10	0.25	-
В	0.013	0.020	0.33	0.51	9
С	0.0075	0.0098	0.19	0.25	-
D	0.3859	0.3937	9.80	10.00	3
Е	0.1497	0.1574	3.80	4.00	4
е	0.050 BSC		1.27 BSC		-
Н	0.2284	0.2440	5.80	6.20	-
h	0.0099	0.0196	0.25	0.50	5
L	0.016	0.050	0.40	1.27	6
Ν	16		16		7
α	0°	8°	0°	8°	-

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¹² intersil